

Appli	icatio	n/Cont	rol	No.
10/84	49.08	9		

Examiner
Rei-tsang Shiao, Ph.D.

Applicant(s)/Patent under Reexamination
NAZARE ET AL.

Art Unit 1626

			ISSUE	CL	AS	SIF	ICAT	ION						
ORIGINAL					INTERNATIONAL CLASSIFICATION									
CLASS SUBCLASS			LASS			С	LAIMED		NON-CLAIMED					
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CLASS	CROSS REFE	RENCES E SUBCLASS PE	R BLOCK)	C	07	D	40	1100			1			
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Resistant Examiner) (Date) JOSEF					K.	VV	Keng	Total Claims Allowed: /O						
				Y PATENT EXAMINER DGY CENTER 1600° 3/22/07				O.G. Print Claim(s) O.G. Print Fig.						

Claims r	Claims renumbered in the same order as presented by applicant						□СРА			` T.D.			☐ R.1.47		
Final	Final Original	Final	Original		Final	Original		Final	Original	,	Final	Original		Final	Original
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